Application/Control No. Applicant(s)/Patent Under Reexamination 09/910,836 TANAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2173 Raymond J. Bayerl **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-2002/0007287 01-2002 Straube et al. 707/10X US-2003/0105393 В 06-2003 SUTHERLAND et al. 600/407 US-6,847,933 C 01-2005 Hastings, Jeffrey S. 600/437X D US-US-Ε F US-G US-Н US-US-1 US-J US-Κ L US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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